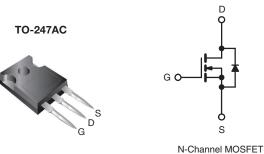


**Vishay Siliconix** 



#### Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	500				
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	0.85			
Q <sub>g</sub> (Max.) (nC)	63				
Q <sub>gs</sub> (nC)	11				
Q <sub>gd</sub> (nC)	30				
Configuration	Single				



#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247AC package preferred for is commercial-industrial applications where higher power levels preclude the use of TO-220AB devices. The TO-247AC is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distances between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247AC
Lead (Pb)-free	IRFP440PbF
	SiHFP440-E3
SnPb	IRFP440
	SiHFP440

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_c = 25 \text{ °C}$ , unless otherwise noted)							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			V <sub>DS</sub>	500	V		
Gate-Source Voltage			V <sub>GS</sub>	± 20	V		
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	1	8.8			
		T <sub>C</sub> = 100 °C	ID	5.6	A		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	35			
Linear Derating Factor				1.2	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	480	mJ		
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	8.8	A		
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	15	mJ		
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	PD	150	W		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	3.5	V/ns		
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for	10 s		300 <sup>d</sup>			
Mounting Torque	6-32 or M3 screw			10	lbf ∙ in		
				1.1	N · m		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD}$  = 50 V, starting T<sub>J</sub> = 25 °C, L = 11 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 8.8 A (see fig. 12).

c.  $I_{SD} \le 8.8$  A, dI/dt  $\le 100$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

Document Number: 91228 S11-0444-Rev. B, 14-Mar-11 www.vishay.com



Vishay Siliconix



Static         V <sub>DS</sub> V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA         500         -         V	THERMAL RESISTANCE RATI	NGS							
Case-to-Sink, Flat, Greased Surface $R_{HCS}$ $0.24$ $ 0.83$ $^{\circ}CW$ SPECIFICATIONS (T <sub>g</sub> = 25 °C, unless otherwise noted)         TEST CONDITIONS         Min.         TYP.         MAX.         UNIT           State         Test conditions         Min.         TYP.         MAX.         UNIT           State         Test conditions         Min.         TYP.         MAX.         UNIT           Organsource Breakdown Votage         Vos         Vos         State         State         No.8         Vos         C.0.2         Vos         Vos         State           Organsource Breakdown Votage         Vos         Vos         State         No.8         Vos         State	PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Case (Drain) $R_{h,uc}$ -         0.83           SPECIFICATIONS (T <sub>J</sub> = 25 °C, unless otherwise noted)         Far Conditions         Min.         TYP.         MAX.         UNIT           Static         Drain-Source Breakdown Voltage         V <sub>DS</sub> V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 µA         500         -         -         V           Gate-Source Inveshold Voltage         V <sub>DS</sub> Reference to 25 °C, I <sub>D</sub> = 1 mA         -         0.78         -         V/C           Gate-Source Inveshold Voltage         V <sub>DS</sub> (T <sub>J</sub> )         Reference to 25 °C, I <sub>D</sub> = 1 mA         -         0.78         -         V/C           Gate-Source Inveshold Voltage         V <sub>DS</sub> (T <sub>J</sub> )         Reference to 25 °C, I <sub>D</sub> = 1 mA         -         0.78         -         V/C           Gate-Source Inveshold Voltage         V <sub>DS</sub> (T <sub>J</sub> )         Reference to 25 °C, I <sub>D</sub> = 1 mA         -         0.78         -         V/C           Orain-Source Co-State Resistance         V <sub>DS</sub> = 400 V, V <sub>DS</sub> = 0 V         -         -         2.50         µ           Orain-Source Co-State Resistance         Gaus         V <sub>DS</sub> = 50 V, I <sub>D</sub> = 5.3 Å         -         -         0.85         Ω           Output Capacitance         Coss         V <sub>DS</sub> = 10 V         I <sub>D</sub> = 5.0 Å, R_S = 60 V, C         - <td>Maximum Junction-to-Ambient</td> <td>R<sub>thJA</sub></td> <td colspan="2" rowspan="2"></td> <td></td> <td colspan="2"></td> <td></td>	Maximum Junction-to-Ambient	R <sub>thJA</sub>							
	Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>					°C/W		
$\begin{array}{ c c c c c c } \hline PARAMETER SYMBOL SYMBOL TEST CONDITIONS MIN. TYP. MAX. UNIT State State $$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$	Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 0.83						
$\begin{array}{ c c c c c c } \hline PARAMETER SYMBOL SYMBOL TEST CONDITIONS MIN. TYP. MAX. UNIT State State $$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$									
Static         VDS         VDS         VDS         VDS         State           Drain-Source Breakdown Voltage $\Delta V_{DS} T_{J}$ Reference to 25 C, to = 1 mA         -         0.78         -         V/C           Gate-Source Intreshold Voltage         VDS         VDS         200         -         4.0         V           Cate-Source Leakage         IDSS         VDS         200         -         4.0         V           Zaro Gate Voltage Drain Current         IDSS         VDS         = 500 V, VDS = 0 V         -         -         250         µ           Prain-Source Con-State Resistance         RDS(m)         VDS = 10 V         ID = 5.3 A <sup>D</sup> -         0.85         0           Drain-Source Con-State Resistance         RDS(m)         VDS = 500 V, VDS = 0 V, TJ = 125 °C         -         -         0.85         0           Drain-Source Charge         Qgs         VDS = 500 V, VDS = 0 V, TJ = 5.3 A <sup>D</sup> -         0.85         0         0         -         0.85         0         0         -         0.85         0         0         -         0.85         0         0         -         0.85         0         0         -         0.85         0         0         -         0.85 </td <td><b>SPECIFICATIONS</b> (<math>T_J = 25 \text{ °C}</math>, u</td> <td>Inless otherwi</td> <td>ise noted)</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td>	<b>SPECIFICATIONS</b> ( $T_J = 25 \text{ °C}$ , u	Inless otherwi	ise noted)						
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	PARAMETER	SYMBOL	TEST	CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Static								
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	) V, I <sub>D</sub> = 2	250 µA	500	-	-	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C,	, I <sub>D</sub> = 1 mA	-	0.78	-	V/°C
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	′ <sub>GS</sub> , I <sub>D</sub> = 2	250 µA	2.0	-	4.0	V
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Gate-Source Leakage	I <sub>GSS</sub>	VG	<sub>iS</sub> = ± 20	V	-	-	± 100	nA
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Zava Cata Valtaga Drain Current	-			<sub>S</sub> = 0 V	-	-	25	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gate voltage Drain Current	IDSS			-	-	250	μA	
DynamicInput CapacitanceCissVGS = 0 V, VDS = 25 V, f = 1.0 MHz, see fig. 5-1300-Output CapacitanceCoss $V_{GS} = 0 V,$ VDS = 25 V, f = 1.0 MHz, see fig. 5-1300-Reverse Transfer CapacitanceCrssf = 1.0 MHz, see fig. 5-120-Total Gate ChargeQg Qga $V_{GS} = 10 V$ $I_D = 8.0 A, V_{DS} = 400 V$ see fig. 6 and 13b63Gate-Drain ChargeQgd $V_{GS} = 10 V$ $I_D = 8.0 A, V_{DS} = 400 V$ see fig. 6 and 13b63Turn-On Delay Timet_d(off) $V_{GS} = 10 V$ $V_{GS} = 31 \Omega$ , see fig. 10b14Rise Timetr $V_{CS} = 10 V$ $V_{DS} = 250 V, I_D = 8.0 A,$ $R_g = 9.1 \Omega, R_D = 31 \Omega$ , see fig. 10b-14-Fall Timetr $V_{DS} = 250 V, I_D = 8.0 A,$ $G mm (0.25^{\circ})$ from package and center of die contact-5.0Internal Drain InductanceL_DBetween lead, $6 mm (0.25^{\circ})$ from package and center of die contact-5.0Internal Source InductanceL_SMOSFET symbol shwing the integral reverse $p - n$ junction diode8.8APulsed Diode Characteristics3.52.0VBody Diode Reverse Recovery Timetr,T_J = 25 °C, I_S = 8.8 A, V_{GS} = 0 V^b2.0VBody Diode Reverse Recovery ChargeQrrT_J = 25 °C, I_S = 8.0 A, dI/dt = 100 A/\mu s^b	Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I	<sub>D</sub> = 5.3 A <sup>b</sup>	-	-	0.85	Ω
$ \begin{array}{ c c c c c c c } \hline Input Capacitance & C_{iss} & V_{GS} = 0 \ V, & V_{DS} = 25 \ V, & I_{DS} = 25 \ V, & I_{S} = 10 \ MHz, see fig. 5 & I_{C} & 310 & - & P \\ \hline & & 310 & - & P \\ \hline & & 310 & - & P \\ \hline & & 310 & - & P \\ \hline & & 310 & - & P \\ \hline & & 120 & - & I_{C} & I_{$	Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 5	0 V, I <sub>D</sub> =	5.3 A <sup>b</sup>	5.3	-	-	S
$ \begin{array}{ c c c c c c } \hline U_{DU} U_{D} Capacitance & C_{oss} & V_{DS} = 25 \ V, & f = 1.0 \ MHz, see fig. 5 & f = 1.0 \ MHz, see fig. 5 & f = 1.0 \ MHz, see fig. 5 & f = 1.0 \ MHz, see fig. 5 & f = 1.0 \ MHz, see fig. 5 & f = 1.0 \ MHz, see fig. 5 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & - & 63 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & - & 30 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & - & 30 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & - & 30 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & - & 30 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & - & 30 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & - & - & 30 & f = 1.0 \ MHz, see fig. 6 \ and 13^b & - & - & - & - & - & - & - & - & - & $	Dynamic								
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V,		-	1300	-	pF	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 25 V,			-	310		-
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5			-	120		-
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Total Gate Charge	Qg				-	-	63	nC
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 V$		-	-	11	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Drain Charge	Q <sub>gd</sub>		566	ig. 6 and 135	-	-	30	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-On Delay Time	t <sub>d(on)</sub>		1		-	14	-	
$\begin{tabular}{ c c c c c c } \hline Turn-Off Delay Time & t_d(off) & R_g = 9.1 \ \Omega, \ R_D = 31 \ \Omega, \ see fig. 10^b & - & 49 & - & \\ \hline R_g = 9.1 \ \Omega, \ R_D = 31 \ \Omega, \ see fig. 10^b & - & 20 & - & \\ \hline - & 20 & - & & \\ \hline - & 20 & - & & \\ \hline - & 5.0 & - & & \\ \hline - & 13 & - & & \\ \hline - & 14 & & \\ \hline - & 13 & - & & \\ \hline - & 13$	Rise Time		V <sub>DD</sub> = 2	V <sub>DD</sub> = 250 V. I <sub>D</sub> = 8.0 A.		-	23	-	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-Off Delay Time	t <sub>d(off)</sub>	$B_{a} = 9.1 \Omega$ , $B_{D} = 31 \Omega$ , see fig. $10^{b}$		-	49	-	ns	
Internal Drain InductanceLD6 mm (0.25") from package and center of die contact-5.0-nHInternal Source InductanceLs $A_S$ $A_S$ -13nHDrain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIsMOSFET symbol showing the integral reverse p - n junction diode8.8APulsed Diode Forward CurrentaIsMOSFET symbol showing the integral reverse p - n junction diode8.8ABody Diode VoltageVsDTJ = 25 °C, Is = 8.8 A, VGS = 0 Vb2.0VBody Diode Reverse Recovery Timetrr TJ = 25 °C, IF = 8.0 A, dI/dt = 100 A/µsb-460970nsBody Diode Reverse Recovery ChargeQrrTJ = 25 °C, IF = 8.0 A, dI/dt = 100 A/µsb-3.57.6µC	Fall Time	t <sub>f</sub>		0	,,	-	20	-	
Internal Source InductanceLspackage and center of die contactImage: Contact of the contact of	Internal Drain Inductance	L <sub>D</sub>	6 mm (0.25") from package and center of		-	5.0	-		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Internal Source Inductance	L <sub>S</sub>			-	13	-	nH	
Continuous source-brain blode currentIsshowing the integral reverse p - n junction diode8.8APulsed Diode Forward CurrentaIsIs $I_{SM}$ $T_J = 25 ^{\circ}C$ , Is = 8.8 A, VGS = 0 Vb35ABody Diode VoltageVSD $T_J = 25 ^{\circ}C$ , Is = 8.8 A, VGS = 0 Vb2.0VBody Diode Reverse Recovery Time $t_{rr}$ $T_J = 25 ^{\circ}C$ , IF = 8.0 A, dI/dt = 100 A/µsb-460970nsBody Diode Reverse Recovery Charge $Q_{rr}$ $Q_{rr}$ -3.57.6µC	Drain-Source Body Diode Characteristic	cs					•	•	
Pulsed Diode Forward CurrentaI I SMIntegration diodeI P - n junction diode35Body Diode VoltageVSDTJ = 25 °C, IS = 8.8 A, VGS = 0 Vb2.0VBody Diode Reverse Recovery TimetrrTJ = 25 °C, IF = 8.0 A, dI/dt = 100 A/µsb-460970nsBody Diode Reverse Recovery ChargeQrr3.57.6µC	Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the lintegral reverse		-	-	8.8	A	
Body Diode Reverse Recovery Time $t_{rr}$ $T_J = 25 \ ^{\circ}C$ , $I_F = 8.0 \ ^{\circ}A$ , $dI/dt = 100 \ ^{\circ}A/\mu s^b$ -460970nsBody Diode Reverse Recovery Charge $Q_{rr}$ $T_J = 25 \ ^{\circ}C$ , $I_F = 8.0 \ ^{\circ}A$ , $dI/dt = 100 \ ^{\circ}A/\mu s^b$ -3.57.6 $\mu C$	Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	35		
Body Diode Reverse Recovery Charge $Q_{rr}$ $T_J = 25 \ ^{\circ}C$ , $I_F = 8.0 \ ^{\circ}A$ , $dl/dt = 100 \ ^{\circ}A/\mu s^b$ -3.57.6 $\mu C$	Body Diode Voltage	V <sub>SD</sub>	$T_J = 25 \text{ °C}, I_S = 8.8 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	2.0	V	
Body Diode Reverse Recovery Charge Q <sub>rr</sub> - 3.5 7.6 µC	Body Diode Reverse Recovery Time	t <sub>rr</sub>			-	460	970	ns	
Forward Turn-On Time ton Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )	Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.5	7.6	μC	
	Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn			i-on is dor	minated b	y L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

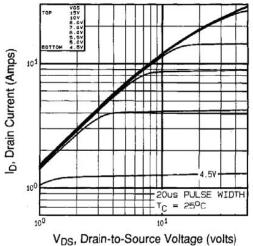
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

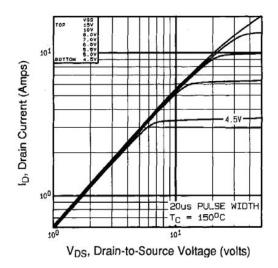


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

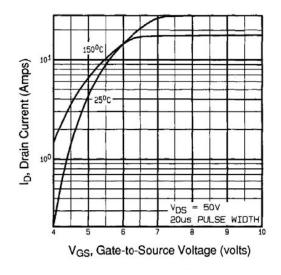


Fig. 3 - Typical Transfer Characteristics

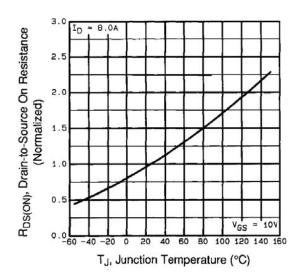


Fig. 4 - Normalized On-Resistance vs. Temperature

Document Number: 91228 S11-0444-Rev. B, 14-Mar-11

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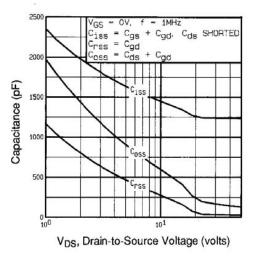


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

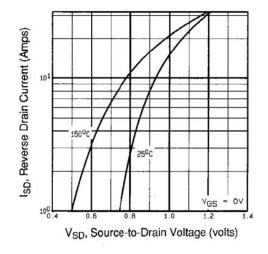


Fig. 7 - Typical Source-Drain Diode Forward Voltage

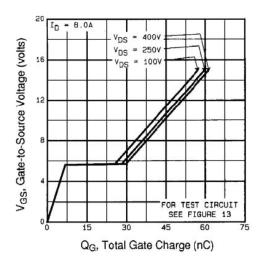


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

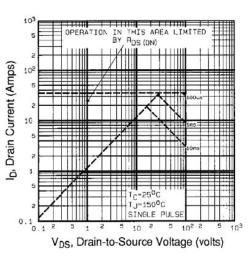


Fig. 8 - Maximum Safe Operating Area

Document Number: 91228 S11-0444-Rev. B, 14-Mar-11



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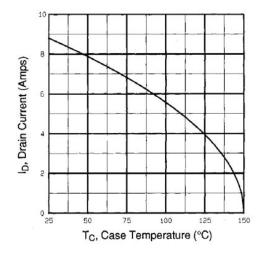


Fig. 9 - Maximum Drain Current vs. Case Temperature

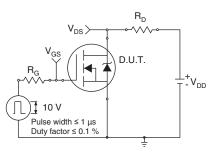


Fig. 10a - Switching Time Test Circuit

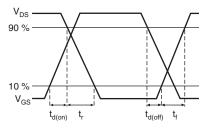


Fig. 10b - Switching Time Waveforms

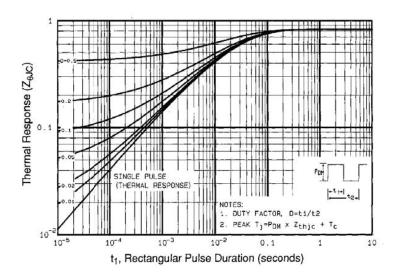


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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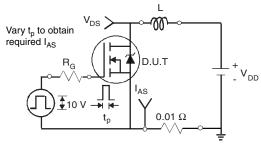


Fig. 12a - Unclamped Inductive Test Circuit

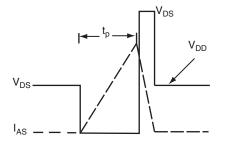


Fig. 12b - Unclamped Inductive Waveforms

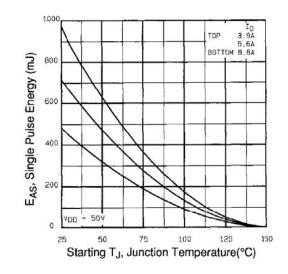


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

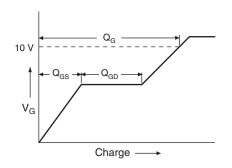
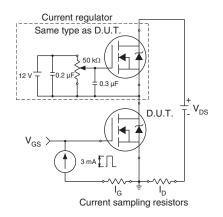


Fig. 13a - Basic Gate Charge Waveform



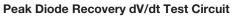


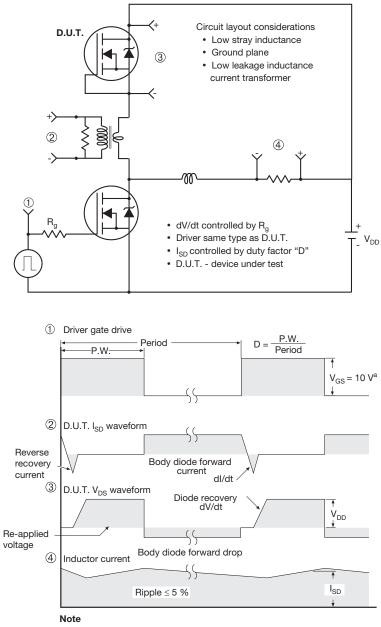
Document Number: 91228 S11-0444-Rev. B, 14-Mar-11



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a.  $V_{GS} = 5$  V for logic level devices

Fig.14 - For N-Channel

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#### TO-247AC (High Voltage)

ECN: X13-0103-Rev. D, 01-Jul-13 DWG: 5971

#### Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Contour of slot optional.

 Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.

4. Thermal pad contour optional with dimensions D1 and E1.

5. Lead finish uncontrolled in L1.

6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").

7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.

8. Xian and Mingxin actually photo.





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